corrections for Figures 1, 2, 6 and 7, including any additional changes in response to form PTO-948, when the application is allowed by Examiner.

IN THE CLAIMS

Please amend claims 1 and 15 as follows:

1. (Amended) A scanning force microscope probe, comprising:

a cantilever having a first end and a second end; and

a reflective structure included on the cantilever such that at least a portion of light that is directed substantially through free space to the cantilever in a first direction having a directional component from the first end to the second end is reflected from the reflective structure substantially through free space in a second direction having a directional component from the second end to the first end.

15. (Amended) A method of detecting motion of a scanning force microscope probe cantilever, the cantilever having a first end and a second end, the method comprising:

directing light to the cantilever in a first direction substantially through free space having a directional component from the first end to the second end of the cantilever;

reflecting at least a portion of the light from the cantilever in a second direction substantially through free space having a directional component from the second end to the first end of the cantilever; and

receiving the portion of the light reflected from the cantilever to detect motion of the cantilever.

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Examiner: Daniel Larkin

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